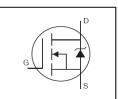


Features

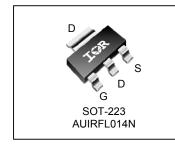
- Advanced Planar Technology
- Low On-Resistance
- · Dynamic dv/dt Rating
- 150°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this Cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V _{DSS}	55V
R _{DS(on)} max.	0.16Ω
I _D	1.9A



G	D	S
Gate	Drain	Source

Page part number Pagkage Type		Standard Pack		Orderable Bout Number	
Base part number	Package Type	Form Quantity		Orderable Part Number	
AUIRFL014N	SOT-223	Tape and Reel	2500	AUIRFL014NTR	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V ®	2.7		
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V ®	1.9		
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V ®	1.5	A	
I _{DM}	Pulsed Drain Current ①	15		
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) ©	2.1	10/	
P _D @T _A = 25°C	Maximum Power Dissipation (PCB Mount) ⑤	1.0	W	
	Linear Derating Factor (PCB Mount) S	8.3	W/°C	
V _{GS} Gate-to-Source Voltage		± 20	V	
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	48	mJ	
I _{AR}	Avalanche Current ①	1.7	А	
E _{AR}	Repetitive Avalanche Energy ①⑤	0.1	mJ	
dv/dt Peak Diode Recovery dv/dt ③		5.0	V/ns	
T_J	Operating Junction and	-55 to + 150	°C	
T _{STG}	Storage Temperature Range			

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) ©	90	120	°C // //
$R_{ heta JA}$	Junction-to-Ambient (PCB Mount, steady state) ®	50	60	°C/W

 $\label{eq:hexpectation} \mbox{HEXFET} \mbox{\ensuremath{\mathbb{R}}} \mbox{ is a registered trademark of Infineon}.$

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.054		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.16	Ω	V _{GS} = 10V, I _D = 1.9A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	1.6			S	$V_{DS} = 25V, I_{D} = 0.85A$
	Drain-to-Source Leakage Current			1		$V_{DS} = 44V$, $V_{GS} = 0V$
I _{DSS}	Dialii-to-Source Leakage Current			25	μA	$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			100	n ^	V _{GS} = 20V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 7.0	11		I _D = 1.7A
Q_{gs}	Gate-to-Source Charge	 1.2	1.8	nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain Charge	 3.3	5.0		V _{GS} = 10V, See Fig 6 and 9 ④
$t_{d(on)}$	Turn-On Delay Time	6.6			$V_{DD} = 28V$
t _r	Rise Time	 7.1		20	I _D = 1.7A
$t_{d(off)}$	Turn-Off Delay Time	 12		ns	$R_G = 6.0\Omega$
t _f	Fall Time	 3.3			R_D = 16 Ω , See Fig. 10 \oplus
C_{iss}	Input Capacitance	 190			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 72		pF	V _{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	 33			f = 1.0MHz, See Fig.5

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			1.3		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			15		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.0	V	$T_J = 25^{\circ}C, I_S = 1.7A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		41	61	ns	$T_J = 25^{\circ}C$, $I_F = 1.7A$,
Q _{rr}	Reverse Recovery Charge		64	95	nC	di/dt = 100A/µs ④

Notes

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② V_{DD} = 25V, starting T_J = 25°C, L = 8.2mH, R_G = 25 Ω , I_{AS} = 3.4A. (See fig. 12)
- ③ $I_{SD} \le 1.7A$, di/dt $\le 250A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J \le 150^{\circ}C$.
- 4 Pulse width $\leq 400 \mu s$; duty cycle $\leq 2\%$.
- © When mounted on FR-4 board using minimum recommended footprint.
- © When mounted on 1 inch square copper board, for comparison with other SMD devices.



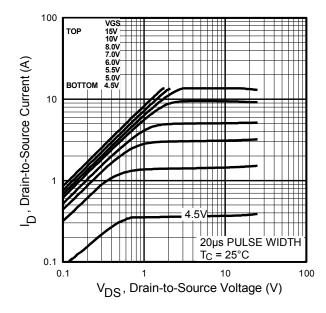


Fig. 1 Typical Output Characteristics

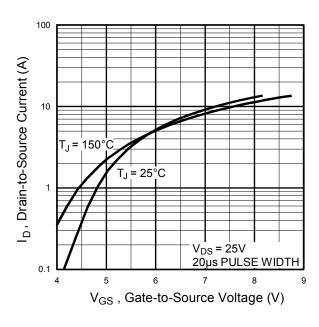


Fig. 3 Typical Transfer Characteristics

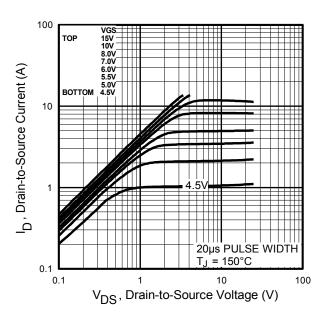


Fig. 2 Typical Output Characteristics

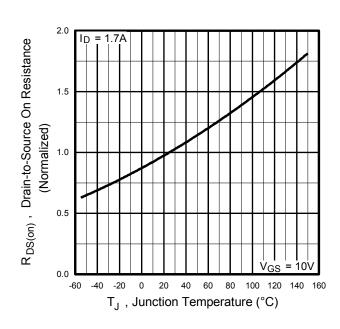


Fig. 4 Normalized On-Resistance vs. Temperature

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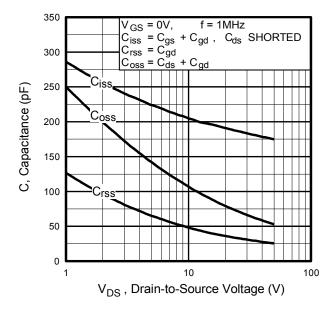


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

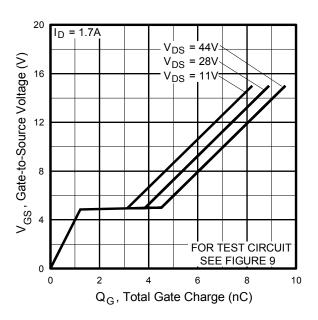


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

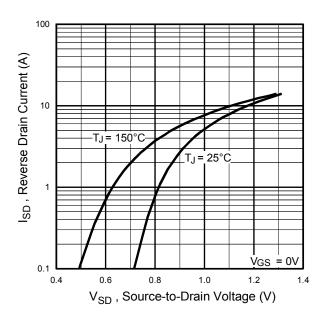


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

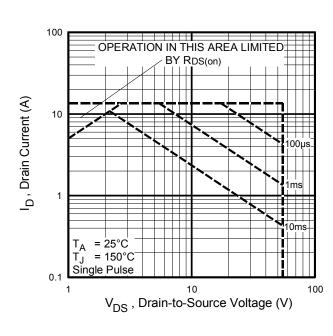


Fig 8. Maximum Safe Operating Area



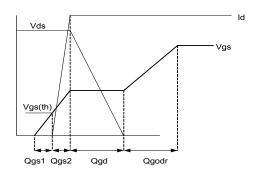


Fig 9a. Basic Gate Charge Waveform

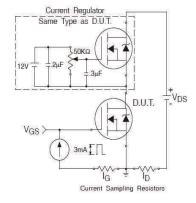


Fig 9b. Gate Charge Test Circuit

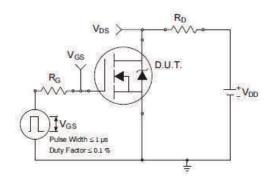


Fig 10a. Switching Time Test Circuit

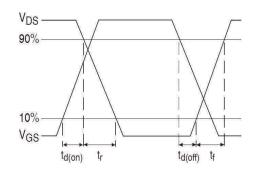


Fig 10b. Switching Time Waveforms

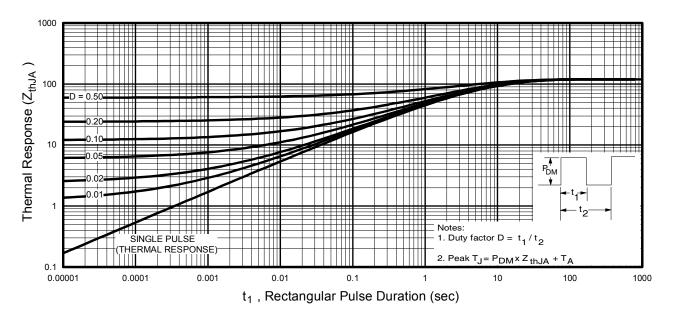


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



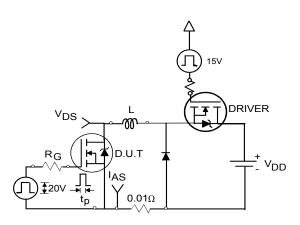


Fig 12a. Unclamped Inductive Test Circuit

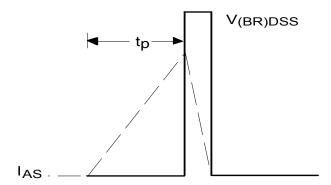


Fig 12b. Unclamped Inductive Waveforms

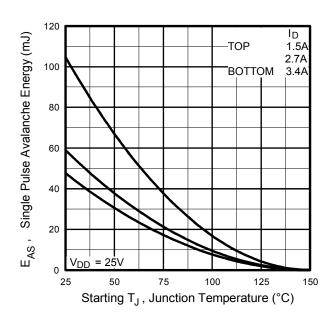
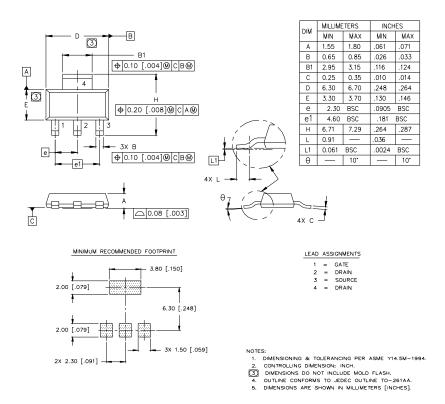


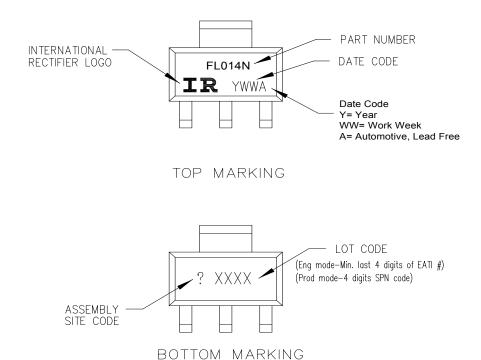
Fig 12c. Maximum Avalanche Energy Vs. Drain Current



SOT-223 (TO-261AA) Package Outline (Dimensions are shown in millimeters (inches)



SOT-223(TO-261AA) Part Marking Information

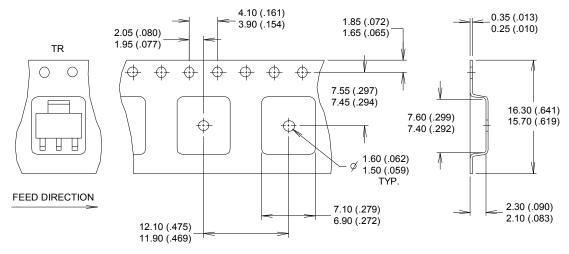


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Downloaded from Arrow.com.

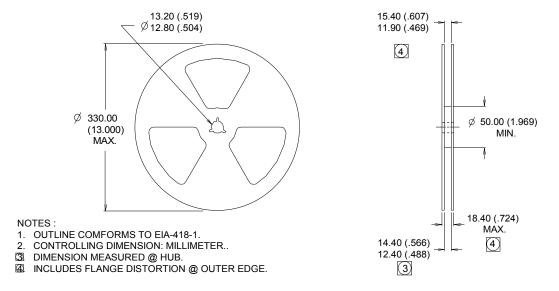


SOT-223(TO-261AA) Tape and Reel (Dimensions are shown in millimeters (inches)



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
- 3. EACH Ø330.00 (13.00) REEL CONTAINS 2,500 DEVICES.



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

2015-10-5



Qualification Information

		Automotive					
		(per AEC-Q101)					
Qualificati	ion Level	Comments: This part number(s) passed Automotive qualification. Infineor Industrial and Consumer qualification level is granted by extension of the high Automotive level.					
Moisture	Sensitivity Level	SOT-223 MSL1					
			Class M1A (+/- 50V) [†]				
	Machine Model	AEC-Q101-002					
FOD	Lluman Dady Madal	Class H1A (+/- 350V) [†]					
ESD	Human Body Model	AEC-Q101-001					
Observed Davis Made		Class C5 (+/- 2000V) [†]					
	Charged Device Model	AEC-Q101-005					
RoHS Cor	npliant	Yes					

[†] Highest passing voltage.

Revision History

Date	Comments		
3/26/2014	Updated part marking on page 7		
3/20/2014	Updated data sheet with new IR corporate template		
10/5/2015	Updated datasheet with corporate template		
10/5/2015	Corrected ordering table on page 1.		

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